2.0X1.2X0.5 (mm) WiFi/Bluetooth Ceramic Chip Antenna (YF2012H1) Engineering Specification

1. Product Number

YF	2012	H1	P	2	G 45
1	2	3	4	5	6

(1)Product Type	Chip Antenna
(2)Size Code	2.0x1.2x0.5mm
(3)Type Code	H1
(4)Packing	Paper &Reel
(5)Frequency	2.45GHz

SHEN ZHEN YINGFENG ANTENNA TECHNOLOGYCO.,LTD

412, Building 7, Phase II, Nanshan Yungu Entrepreneurship Park, No. 2 Pingshan 1st Road, Pingshan Community, Taoyuan Street, Nanshan District, Shenzhen

2. Features

*Stable and reliable in performances
*Low temperature coefficient of frequency
*Low profile, compact size
*RoHS compliance
*SMT processes compatible

3. Applications

*Bluetooth earphone systems
*Hand-held devices when WiFi /Bluetooth functions are needed, e.g., Smart phone.
*IEEE802.11 b/g/n
*ZigBee
*Wireless PCMCIA cards or USB dongle

4. Description

Yingfeng chip antenna series are specially designed for WiFi/Bluetooth applications. Based on yingfeng proprietary design and processes, this chip antenna has excellent stability and sensitivity to consistently provide high signal reception efficiency.

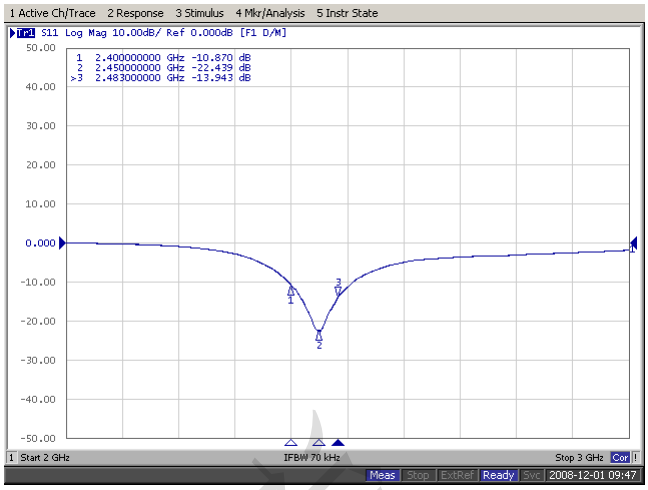
5. Electrical Specifications (80 x 40 mm^2 ground plane)

5-1. Electrical Table

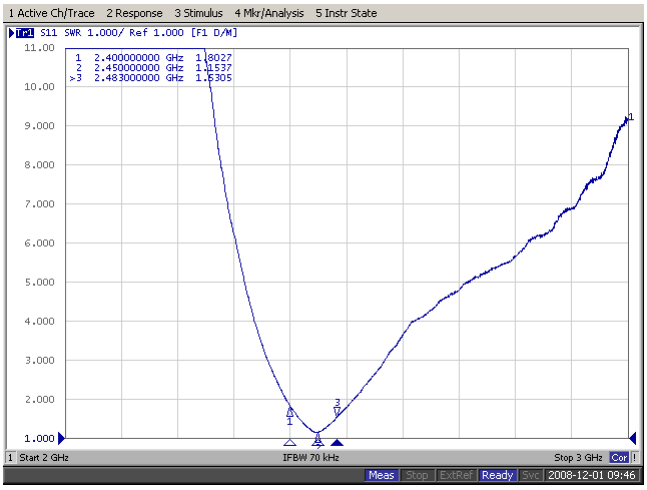
Characteristics		Specifications	Unit
Outline Dimensions		2.0x1.2x0.5	mm
Working Frequency		2400~2500	MHz
VSWR		2 Max.	
Impedance		50	Ω
Polarization		Linear Polarization	
Gain	Peak	2.5 (typical)	dBi
	Efficiency	75 (typical)	%

5-2. Return Loss & VSWR

Return Loss (S_{11})

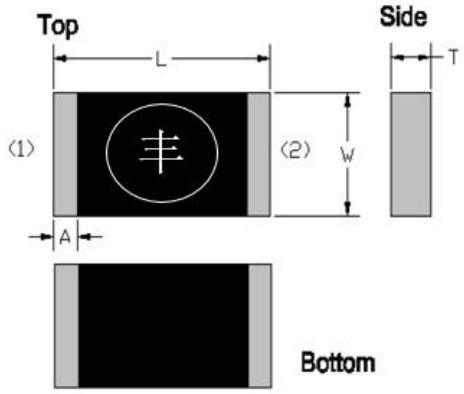


VSWR(S_{11})



6. Antenna Dimensions & Test Board (unit: mm)

a. Antenna Dimensions

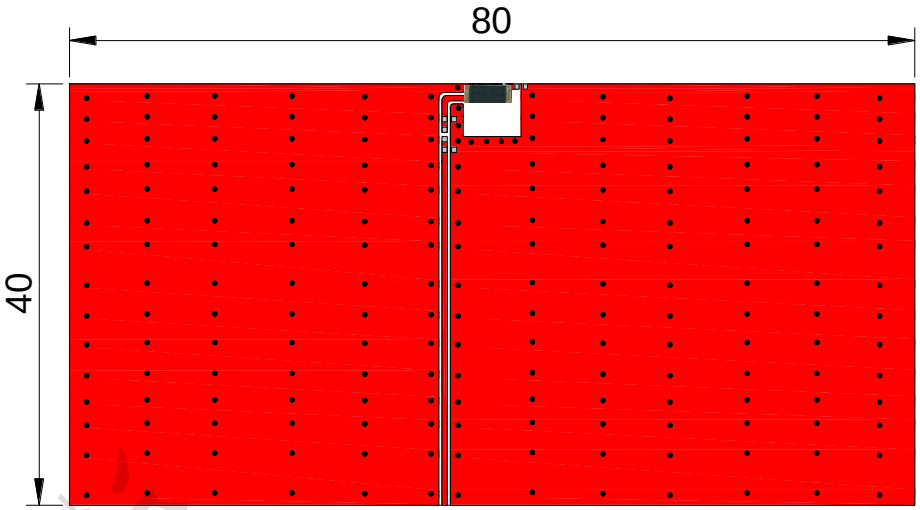


Dimension (mm)	
L	2.05+-0.15
W	1.20+-0.15
T	0.50+-0.10
A	0.20+-0.10

No.	Terminal Name
1	Feeding/GNG
2	GND/Feeding

P.S : Top & down and left & right side are symmetrical, No direction

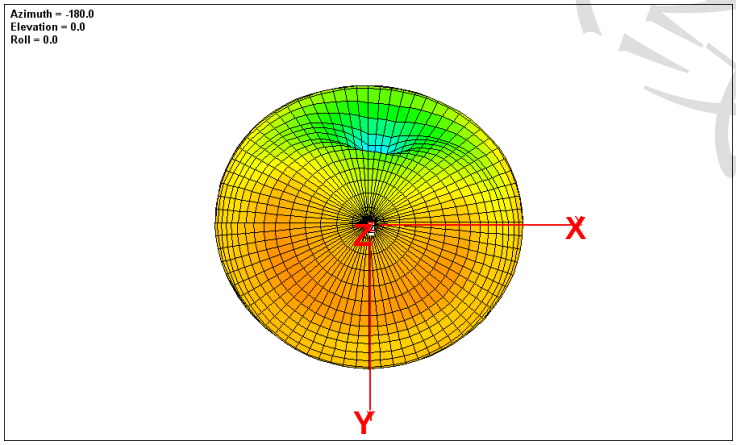
b. Test Board with Antenna

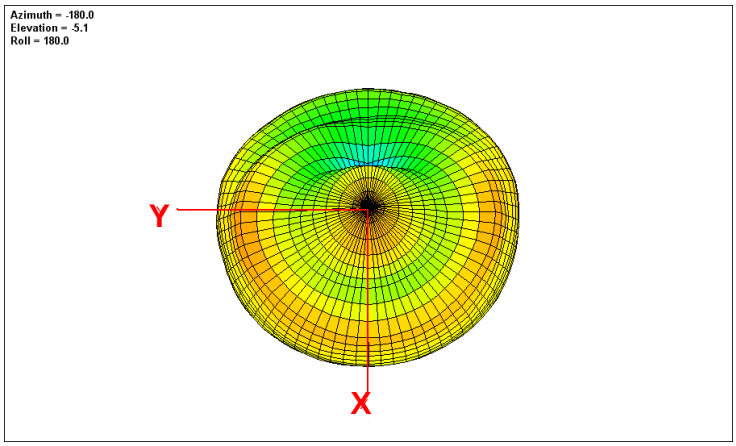


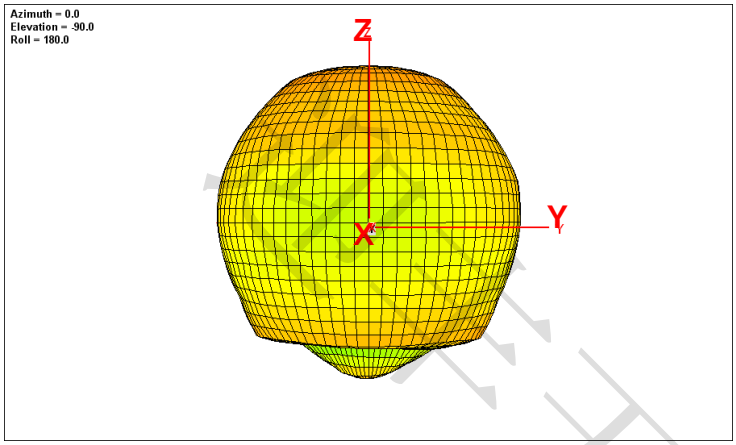
Unit: mm

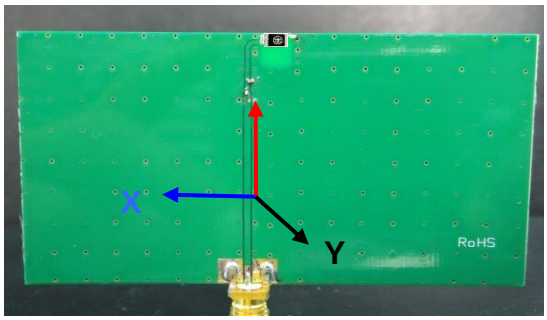
7. Radiation Pattern (80 x 40 mm^2 ground plane)

7-1. 3D Gain Pattern @ 2442 MHz





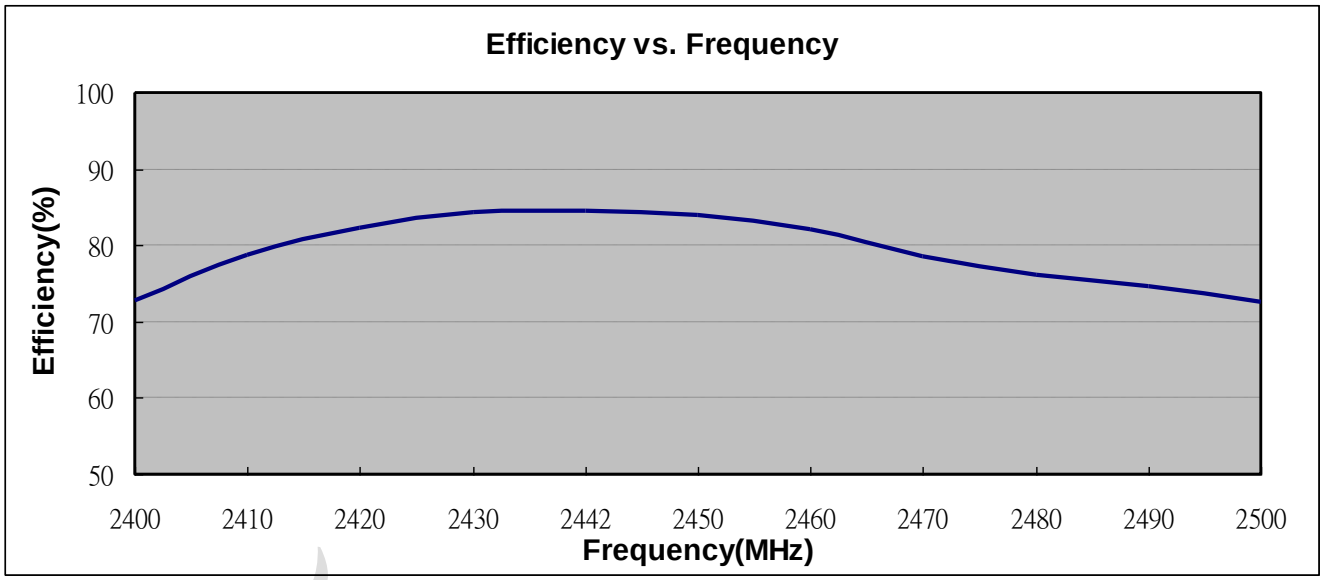




7-2. 3D Efficiency Table

Frequency(MHz)	2400	2410	2420	2430	2442	2450	2460	2470	2480	2490	2500
Efficiency (dB)	-1.4	-1.0	-0.9	-0.7	-0.7	-0.8	-0.9	-1.1	-1.2	-1.3	-1.4
Efficiency (%)	72.8	73.7	74.3	74.4	75.5	75.0	74.0	73.6	73.1	72.6	71.5
Gain (dBi)	2.1	2.2	2.3	2.4	2.5	2.5	2.4	1.8	1.7	1.6	1.4

7-3. 3D Efficiency vs. Frequency



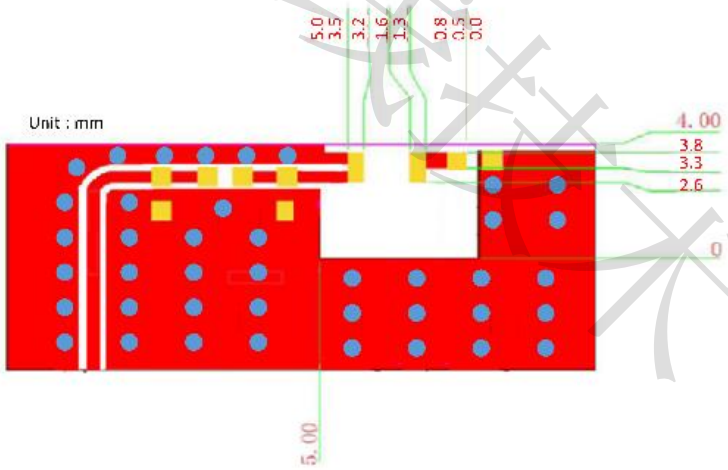
8. Layout Guide

a. Solder Land Pattern:

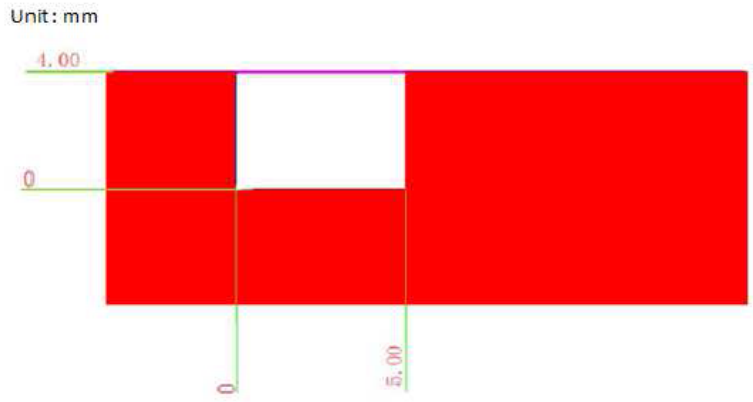
Land pattern for soldering (gray marking areas) is as shown below. Depending on Customer's requirement, matching circuit as shown below is also recommended.

2). PCB Top View :

Type1 :



Top View

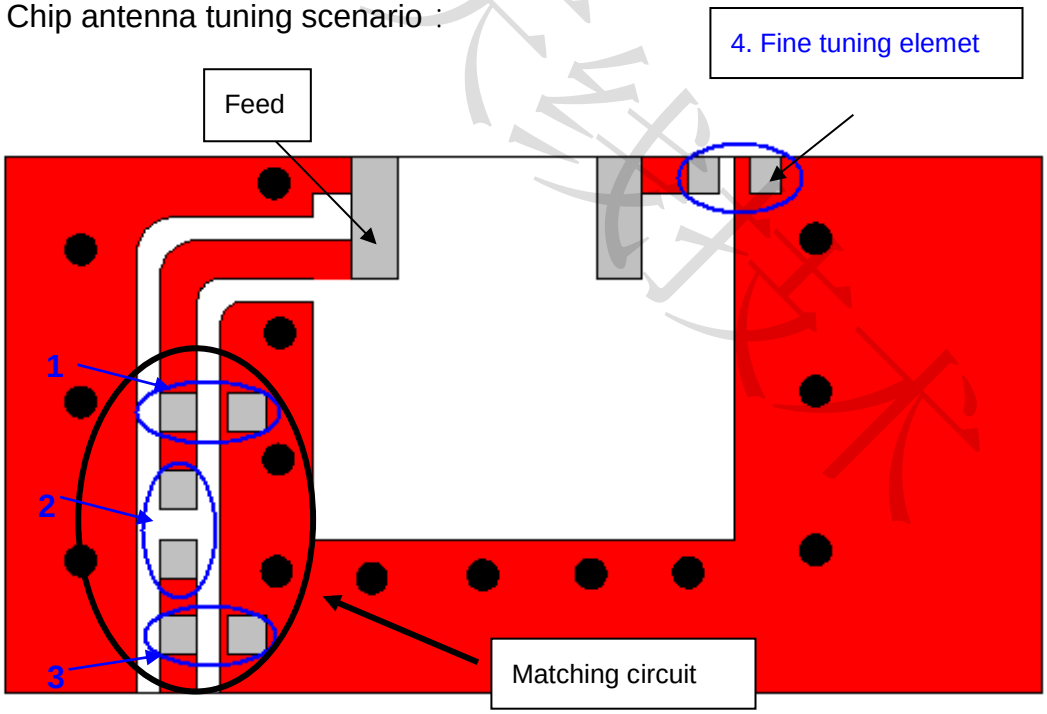


Bottom View

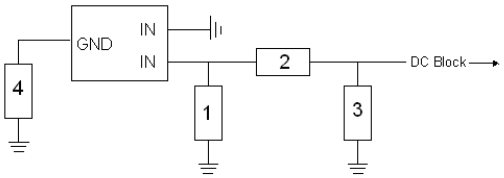
Unit： mm

9. Frequency tuning

a. Chip antenna tuning scenario：



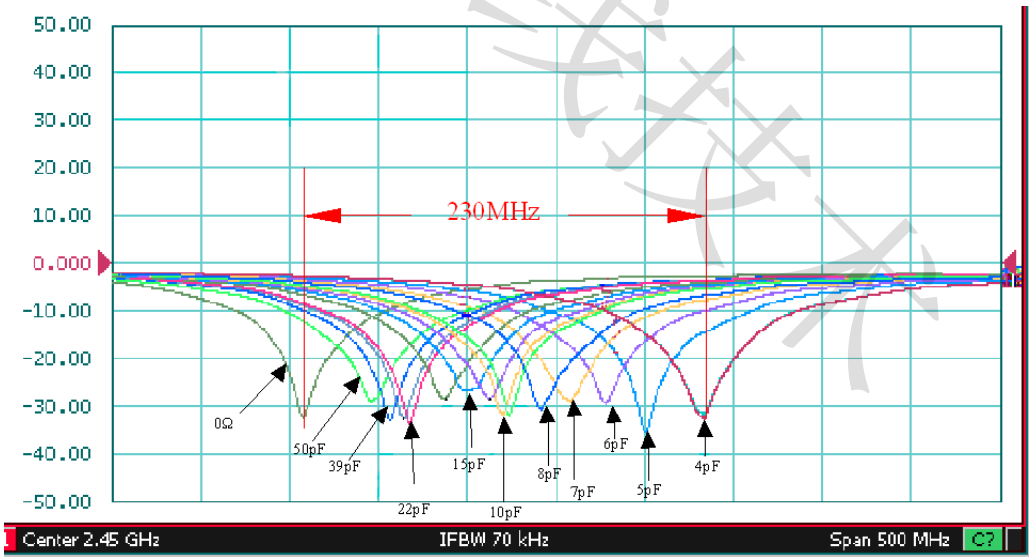
b. Matching circuit：(Center frequency is about 2442 MHz @ 80 x 40 mm^2 ground plane)



System Matching Circuit Component			
Location	Description	Vendor	Tolerance
1	1.2 pF*	Murata (0402)	±0.1 pF
2	10PF*	Murata(0402)	±0.5 PF
3	N/A*	-	-
Fine tuning element 4	10 pF*	Murata (0402)	±0.1 pF

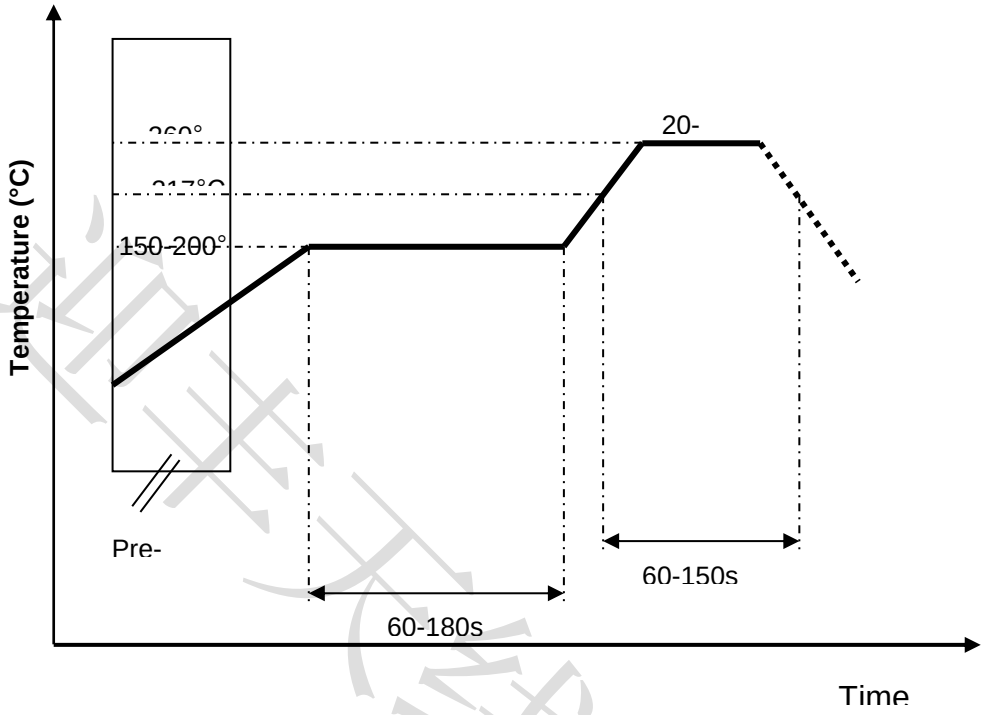
*Typical reference values which may need to be changed when circuit boards or part vendors are different.

c. Fine tuning element vs. Center frequency



10. Soldering Conditions

a. Typical Soldering Profile for Lead-free Process

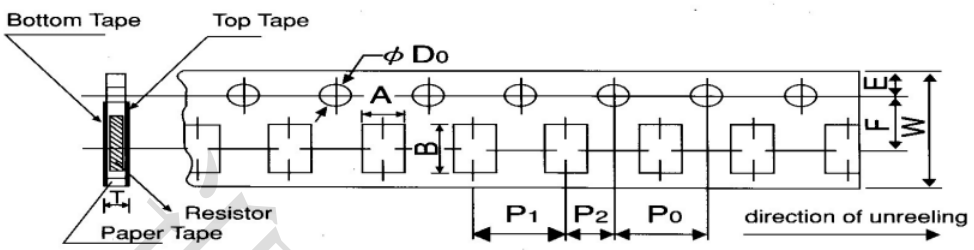


深圳市迎丰天线技术有限公司

11. Packing

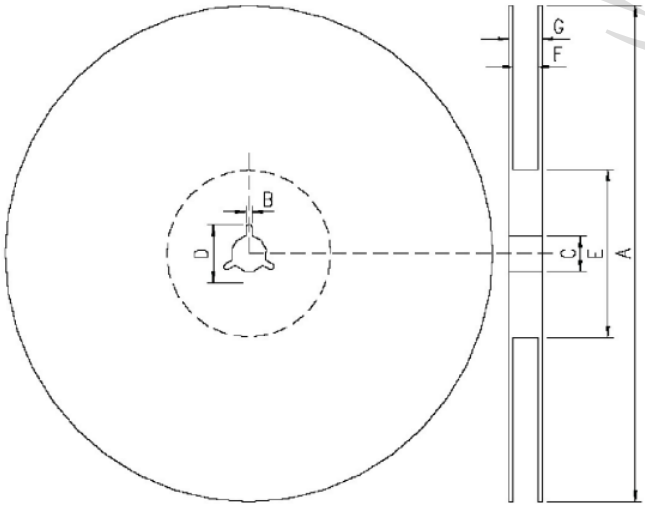
(1) Quantity/Reel: 5000 pcs/Reel

(2) Plastic tape:



Packing	Style	A	B	W	F	E	P_1	P_2	P_0	D_0	T
Paper	2012	1.6±0.15	2.4±0.2	8.0±0.2	3.5±0.05	1.75±0.1	4.0±0.1	2.0±0.05	4.0±0.1	$\psi 1.5^{+0.1}_{-0}$	**0.84±0.1**

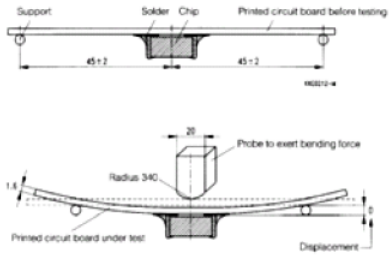
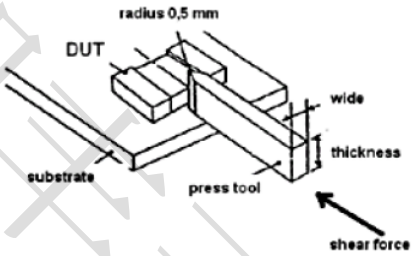
(3) Taping reel dimensions



A	178.0±2.0
B	2.0±0.5
C	13.0±0.5
D	21.0±0.8
E	62.0±1.5
F	9.0±0.5
G	13.0±1.0

Reliability Table

Test Item	Procedure	Requirements Ceramic Type	Remark (Reference)
Electrical Characterization		Fulfill the electrical specification	User Spec.
Thermal Shock	1. Preconditioning: 50 ± 10℃ / 1 hr , then keep for 24 ± 1 hrs at room temp. 2. Initial measure: Spec: refer Initial spec. 3. Rapid change of temperature test: -30℃ to +85℃; 100 cycles; 15 minutes at Lower category temperature; 15 minutes at Upper category temperature.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 107
Temperature Cycling	1. Initial measure: Spec: refer Initial spec. 2. 100 Cycles (-30℃ to +85℃), Soak Mode=1 (2 Cycle/hours). 3. Measurement at 24 ± 2Hours after test condition.	No Visible Damage. Fulfill the electrical specification.	JESD22 JA104
High Temperature Exposure	1. Initial measure: Spec: refer Initial spec. 2. Unpowered; 500hours @ T=+85℃. 3. Measurement at 24 ± 2 hours after test.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 108
Low Temperature Storage	1. Initial measure: Spec: refer Initial spec. 2. Unpowered: 500hours @ T= -30℃. 3. Measurement at 24 ± 2 hours after test.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 108
Solderability (SMD Bottom Side)	Dipping method: a. Temperature: 235 ± 5°C b. Dipping time: 3 ± 0.5s	The solder should cover over 95% of the critical area of bottom side.	IEC 60384-21/22 4.10
Soldering Heat Resistance (RSH)	Preheating temperature: 150 ± 10°C. Preheating time: 1~2 min. Solder temperature: 260 ± 5°C. Dipping time: 5 ± 0.5s	No Visible Damage.	IEC 60384-21/22 4.10
Vibration	5g's for 20 min., 12 cycles each of 3 orientations Note: Use 8"X5" PCB .031" thick 7 secure points on, one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10-2000 Hz.	No Visible Damage.	MIL-STD-202 Method 204
Mechanical Shock	Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks) Peak value: 1,500g's Duration: 0.5ms Velocity change: 15.4 ft/s Waveform: Half-sine	No Visible Damage.	MIL-STD-202 Method 213
Humidity Bias	1. Humidity: 85% R.H., Temperature: 85 ± 2 °C. 2. Time: 500 ± 24 hours. 3. Measurement at 24 ± 2hrs after test condition.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 Method 106

Board Flex (SMD)	1. Mounting method: IR-Reflow. PCB Size (L:100 × W:40 × T:1.6mm) 2. Apply the load in direction of the arrow until bending reaches 2 mm. 	No Visible Damage.	AEC-Q200 005
Adhesion	Force of 1.8Kg for 60 seconds. 	No Visible Damage Magnification of 20X or greater may be employed for inspection of the mechanical integrity of the device body terminals and body/terminal junction.	AEC-Q200 006
Physical Dimension	Any applicable method using x10 magnification, micrometers, calipers, gauges, contour projectors, or other measuring equipment, capable of determining the actual specimen dimensions.	In accordance with specification.	JESD22 JB100

迎丰天线技术